

Certificate of Analysis

Silicon Carbide, beta
45 - 55 nm, 97.5%
Stock #: 4620KE

Components	Contents (%)
Si _f	< 0.15
Cl	< 0.15
C _f	< 0.75
O	< 1.25

Analytical Techniques:
Gas-volumetric method
IR detector
Potential measurement

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